Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/678,611	SAKAI ET AL.	
Examiner	Art Unit	_
Hai C. Pham	2861	

SEARCHED			
Class	Subclass	Date	Examiner
347	244, 258	4/23/2005	НР
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
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